

Search Notes

Application/Control No.

10/056,294

Examiner

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Applicant(s)/Patent under
Reexamination

ROY ET AL.

Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
370	331	10/5/2005	BQN
370	397	10/5/2005	BQN
455	412	10/5/2005	BQN
455	439	10/5/2005	BQN
455	436	10/5/2005	BQN
455	437	10/5/2005	BQN
370	338	10/5/2005	BQN
370	310.1	10/5/2005	BQN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR; EPO; JPO; DERWENT; IBM-TDB) see search history.	10/5/2005	BQN
Consulted with Wellington Chin	10/5/2005	BQN